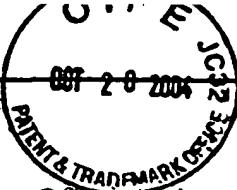


FORM PTO-1849

US DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEApp. Docket No.
86621SLP
Customer No. 01333Serial No.
10/625,964

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24 July 2003Group
2621

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

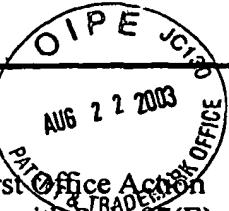
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EXAMINER

/Jordan Kuhn/ (12/05/2006)

DATE CONSIDERED 12/05/2006

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		Filing Date Herewith	Group

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